

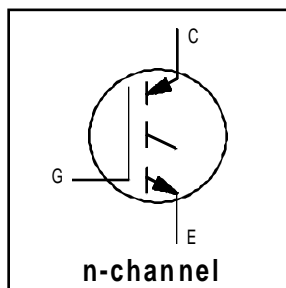
IRGPH40M

INSULATED GATE BIPOLAR TRANSISTOR

Short Circuit Rated
 Fast IGBT

Features

- Short circuit rated - 10 μ s @ 125°C, $V_{GE} = 15V$
- Switching-loss rating includes all "tail" losses
- Optimized for medium operating frequency (1 to 10kHz)

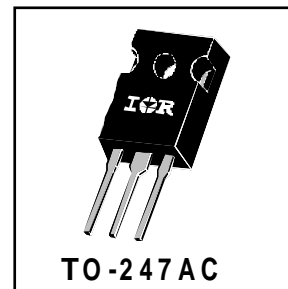


$V_{CES} = 1200V$
$V_{CE(sat)} \leq 3.4V$
@ $V_{GE} = 15V, I_C = 18A$

Description

Insulated Gate Bipolar Transistors (IGBTs) from International Rectifier have higher usable current densities than comparable bipolar transistors, while at the same time having simpler gate-drive requirements of the familiar power MOSFET. They provide substantial benefits to a host of high-voltage, high-current applications.

These new short circuit rated devices are especially suited for motor control and other applications requiring short circuit withstand capability.



Absolute Maximum Ratings

	Parameter	Max.	Units
V_{CES}	Collector-to-Emitter Voltage	1200	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	31	A
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	18	
I_{CM}	Pulsed Collector Current ①	62	
I_{LM}	Clamped Inductive Load Current ②	62	
t_{sc}	Short Circuit Withstand Time	10	μ s
V_{GE}	Gate-to-Emitter Voltage	± 20	V
E_{ARV}	Reverse Voltage Avalanche Energy ③	15	mJ
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	160	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	65	
T_J	Operating Junction and Storage Temperature Range	-55 to +150	$^\circ C$
T_{STG}			
	Mounting torque, 6-32 or M3 screw.	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	-----	-----	0.77	$^\circ C/W$
$R_{\theta CS}$	Case-to-Sink, flat, greased surface	-----	0.24	-----	
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	-----	-----	40	
Wt	Weight	-----	6 (0.21)	-----	g (oz)

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions	
$V_{(BR)CES}$	Collector-to-Emitter Breakdown Voltage	1200	----	----	V	$V_{GE} = 0V, I_C = 250\mu A$	
$V_{(BR)ECS}$	Emitter-to-Collector Breakdown Voltage ④	20	----	----	V	$V_{GE} = 0V, I_C = 1.0A$	
$\Delta V_{(BR)CES}/\Delta T_J$	Temperature Coeff. of Breakdown Voltage	----	1.1	----	$V/^\circ\text{C}$	$V_{GE} = 0V, I_C = 1.0mA$	
$V_{CE(on)}$	Collector-to-Emitter Saturation Voltage	----	2.3	3.4	V	$V_{GE} = 15V$ $I_C = 18A$	
		----	3.0	----			$I_C = 31A$
		----	2.8	----			$I_C = 18A, T_J = 150^\circ\text{C}$
$V_{GE(th)}$	Gate Threshold Voltage	3.0	----	5.5		$V_{CE} = V_{GE}, I_C = 250\mu A$	
$\Delta V_{GE(th)}/\Delta T_J$	Temperature Coeff. of Threshold Voltage	----	-14	----	$mV/^\circ\text{C}$	$V_{CE} = V_{GE}, I_C = 250\mu A$	
g_{fe}	Forward Transconductance ⑤	4.0	10	----	S	$V_{CE} = 100V, I_C = 18A$	
I_{CES}	Zero Gate Voltage Collector Current	----	----	250	μA	$V_{GE} = 0V, V_{CE} = 1200V$	
		----	----	3500		$V_{GE} = 0V, V_{CE} = 1200V, T_J = 150^\circ\text{C}$	
I_{GES}	Gate-to-Emitter Leakage Current	----	----	± 100	nA	$V_{GE} = \pm 20V$	

Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
Q_g	Total Gate Charge (turn-on)	----	50	75	nC	$I_C = 18A$ $V_{CC} = 400V$ $V_{GE} = 15V$
Q_{ge}	Gate - Emitter Charge (turn-on)	----	11	21		
Q_{gc}	Gate - Collector Charge (turn-on)	----	15	30		
$t_{d(on)}$	Turn-On Delay Time	----	30	----	ns	$T_J = 25^\circ\text{C}$ $I_C = 18A, V_{CC} = 960V$ $V_{GE} = 15V, R_G = 10\Omega$ Energy losses include "tail"
t_r	Rise Time	----	21	----		
$t_{d(off)}$	Turn-Off Delay Time	----	400	890		
t_f	Fall Time	----	390	740		
E_{on}	Turn-On Switching Loss	----	1.1	----		
E_{off}	Turn-Off Switching Loss	----	4.0	----	mJ	
E_{ts}	Total Switching Loss	----	5.1	8.0		
t_{sc}	Short Circuit Withstand Time	10	----	----	μs	$V_{CC} = 720V, T_J = 125^\circ\text{C}$ $V_{GE} = 15V, R_G = 10\Omega, V_{CPK} < 1000V$
$t_{d(on)}$	Turn-On Delay Time	----	28	----	ns	$T_J = 150^\circ\text{C}$, $I_C = 18A, V_{CC} = 960V$ $V_{GE} = 15V, R_G = 10\Omega$ Energy losses include "tail"
t_r	Rise Time	----	24	----		
$t_{d(off)}$	Turn-Off Delay Time	----	600	----		
t_f	Fall Time	----	870	----		
E_{ts}	Total Switching Loss	----	9.0	----		
L_E	Internal Emitter Inductance	----	13	----	nH	Measured 5mm from package
C_{ies}	Input Capacitance	----	1360	----	pF	$V_{GE} = 0V$ $V_{CC} = 30V$ $f = 1.0MHz$
C_{oes}	Output Capacitance	----	100	----		
C_{res}	Reverse Transfer Capacitance	----	15	----		

Notes:

- ① Repetitive rating; $V_{GE}=20V$, pulse width limited by max. junction temperature.
- ② $V_{CC}=80\%(V_{CES}), V_{GE}=20V, L=10\mu H, R_G=10\Omega$
- ③ Repetitive rating; pulse width limited by maximum junction temperature.
- ④ Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- ⑤ Pulse width $5.0\mu s$, single shot.

Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>